WHAT IS CLAIMED IS:

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- For use in an integral equation formulation of
 capacitance, a system for generating a representation of charge
 distribution for a given capacitive structure, comprising:
- a charge variation function generator that creates a

 multidimensional charge variation function that is not directly

 dependent on a conductive geometry of said structure; and
 - a conductive geometry generator, associated with said charge variation generator, that creates a representative conductive geometry, wherein said charge variation function is projected on said representative conductive geometry to provide said representation, said charge variation function and said representative conductive geometry employable in said integral equation formulation to reduce a complexity thereof.
 - 2. The system as recited in Claim 1 wherein said integral equation formulation is a Fast Distribution Method.
- The system as recited in Claim 1 wherein said charge
 variation function is a three-dimensional function.
 - 4. The system as recited in Claim 1 wherein said charge variation function is a smooth function of spatial location.

- 5. The system as recited in Claim 1 wherein said conductive geometry generator iteratively creates said representative conductive geometry.
- 6. The system as recited in Claim 1 wherein said charge variation function generator employs a generalized minimal residual-based Krylov method to determine said multidimensional charge variation function.
- 7. The system as recited in Claim 1 wherein said representative conductive geometry is represented in an octtree.

8. For use in an integral equation formulation of capacitance, a method of generating a representation of charge distribution for a given capacitive structure, comprising:

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- creating a multidimensional charge variation function that is not directly dependent on a conductive geometry of said structure; and
- creating a representative conductive geometry, wherein said

 charge variation function is projected on said representative

 conductive geometry to provide said representation, said charge

 variation function and said representative conductive geometry

 employable in said integral equation formulation to reduce a

 complexity thereof.
 - 9. The method as recited in Claim 8 wherein said integral equation formulation is a Fast Distribution Method.
 - 10. The method as recited in Claim 8 wherein said charge variation function is a three-dimensional function.
 - The method as recited in Claim 8 wherein said chargevariation function is a smooth function of spatial location.

- 12. The method as recited in Claim 8 wherein said creating said representative conductive geometry comprises iteratively creating said representative conductive geometry.
- 13. The method as recited in Claim 8 wherein said creating said multidimensional charge variation function comprises employing a generalized minimal residual-based Krylov method to determine said multidimensional charge variation function.
- 14. The method as recited in Claim 8 wherein said representative conductive geometry is represented in an octtree.

- 15. A system for determining a capacitance of a given
 2 integrated circuit, comprising:
- a charge variation function generator that creates a multidimensional charge variation function that is not directly dependent on a conductive geometry of said integrated circuit;

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- a conductive geometry generator that creates a representative conductive geometry, wherein said charge variation function is projected on said representative conductive geometry to provide said representation; and
- an integral equation formulator, associated with said charge
 variation generator and conductive geometry generator, that
 determines said capacitance of said integrated circuit based on
 said charge variation function and said representative conductive
 geometry.
 - 16. The system as recited in Claim 15 wherein said integral equation formulator employs a Fast Distribution Method.
 - 17. The system as recited in Claim 15 wherein said charge variation function is a three-dimensional function.
 - 18. The system as recited in Claim 15 wherein said charge variation function is a smooth function of spatial location.

- 19. The system as recited in Claim 15 wherein said conductive 2 geometry generator iteratively creates said representative 3 conductive geometry.
- 20. The system as recited in Claim 15 wherein said charge variation function generator employs a generalized minimal residual-based Krylov method to determine said multidimensional charge variation function.
- 21. The system as recited in Claim 15 wherein said representative conductive geometry is represented in an octtree.